Electronic Supplementary Information

Clicked Dipicolinic Antennae for Lanthanide Fluorescent Probes

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OPTICAL CHARACTERIZATIONS



Photoluminescence results recorded from europium complexes in OPE conditions

Figure S1. Excitation spectra recorded at RT from europium doped complexes by monitoring the Eu^{3+ 5}D₀ \rightarrow ⁷F₂ transition (616.0 nm).



Figure S2. Emission spectra recorded at RT from europium doped complexes upon excitation in stronger excitation band (see Fig. S2).

Photoluminescence results recorded from terbium complexes in OPE conditions



Figure S3. Excitation spectra recorded at RT from terbium doped complexes by monitoring the Tb^{3+ 5}D₄ \rightarrow ⁷F₅ transition (554.0 nm).



Figure S4. Emission spectra recorded at RT from terbium doped complexes upon excitation in stronger excitation band (see Fig. S3).



Figure S5. Decay curve recorded from compound 9b in OPE conditions.



Figure S6. Decay curve recorded from compound 10d in OPE conditions.

Photoluminescence results recorded from complexes 9b and 10d in TPE conditions



Figure S7. Excitation spectrum recorded at RT from complexe **9b** by monitoring the Eu³⁺ ${}^{5}D_{0} \rightarrow {}^{7}F_{2}$ transition (616.0 nm) in TPE range.



Figure S8. Emission spectrum recorded at RT from complexe **9b** upon TPE conditions at 762 nm.



Figure S9. Excitation spectrum recorded at RT from complexe **10d** by monitoring the Tb^{3+} ${}^{5}D_{4} \rightarrow {}^{7}F_{5}$ transition (544.0 nm) in TPE range.



Figure S10. Emission spectrum recorded at RT from complexe 10d upon TPE conditions at 757 nm.



Figure S11. Decay curve recorded from compound 9b in TPE conditions.



Figure S12. Decay curve recorded from compound 9b in TPE conditions.

Photoluminescence spectra recorded from complexes 9b and 10d in THPE conditions



Figure S13. Excitation spectrum recorded at RT from complexe **9b** by monitoring the Eu³⁺ ${}^{5}D_{0} \rightarrow {}^{7}F_{2}$ transition (616.0 nm) in THPE range.



Figure S14. Excitation spectrum recorded at RT from complexe **10d** by monitoring the Tb³⁺ ${}^{5}D_{4} \rightarrow {}^{7}F_{5}$ transition (544.0 nm) in THPE range.

Remark: Emission spectra as well as decay curves are not presented since the signal to noise ratio was too weak to get suitable data.

PREPARATION AND CHARACTERIZATION OF COATINGS

Coatings preparation

The hybrid films were prepared from the solution of $Ln(12)_3$ (Ln = Eu, Tb) in ethanol via the method of spin-coating. Typically, the detailed procedure for the spin-coating is as follows: Compound 12 (152 mg, 0.28 mmol, 3 equivalents) and $Ln(NO_3)_3 \cdot 6H_2O$ (0.094 mmol, 1 equivalent) were dissolved, under argon and at room temperature, in 3 mL of anhydrous ethanol. After sirring for 10 hours, the solution was carefully dropped into the middle of the clean glass substrate. The transparent films were obtained with a rotation speed of 5000 rpm for 2 minutes, and after drying at 80 °C in an oven for 2 hours.

Profilometry analyses



Figure S15. Profilometry analysis from 13a derived film: the thickness is about 430 nm.



Figure S16. Profilometry analysis from 13b derived film: the thickness is about 444 nm.

Scanning electron microscopy analysis



Figure S17. SEM micrograph recorded from 13a derived coating.

Photoluminescence results from films



Figure S18. Emission spectrum recorded at RT from **13a** derived film upon excitation at 346.5 nm.



Figure S19. Emission spectrum recorded at RT from **13b** derived film upon excitation at 346.5 nm.